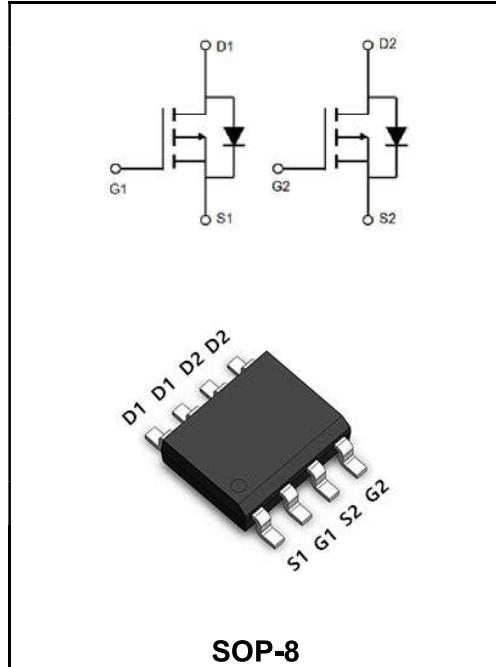


-30V P+P-CHANNEL ENHANCEMENT MODE MOSFET
MAIN CHARACTERISTICS

I_D	-7A
V_{DSS}	-30V
$R_{DS(on)-typ}(@V_{GS}=10V)$	< 48mΩ (Type:37Ω)


Application

- ◆ Lithium battery protection
- ◆ Wireless impact
- ◆ Mobile phone fast charging

Product Specification Classification

Part Number	Package	Marking	Pack
YFW4953S	SOP-8	YFW 4953 XXXXX	3000PCS/Tape

Maximum Ratings at $T_c=25^\circ\text{C}$ unless otherwise specified

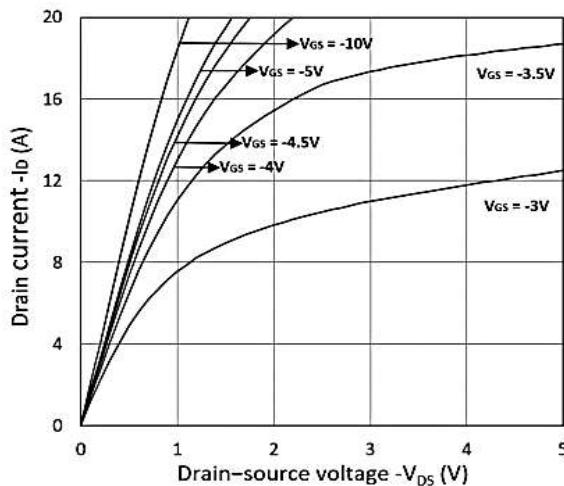
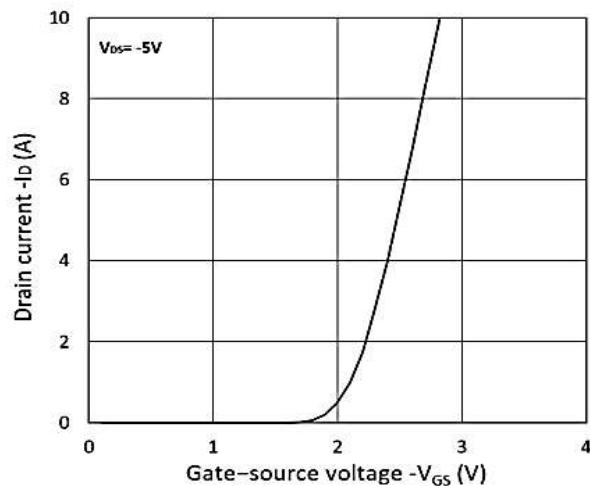
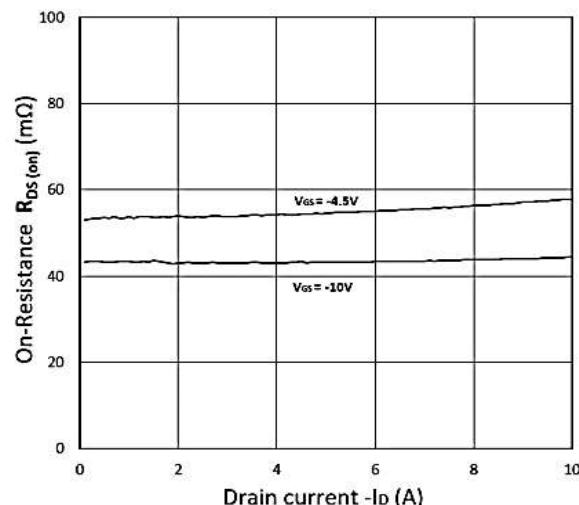
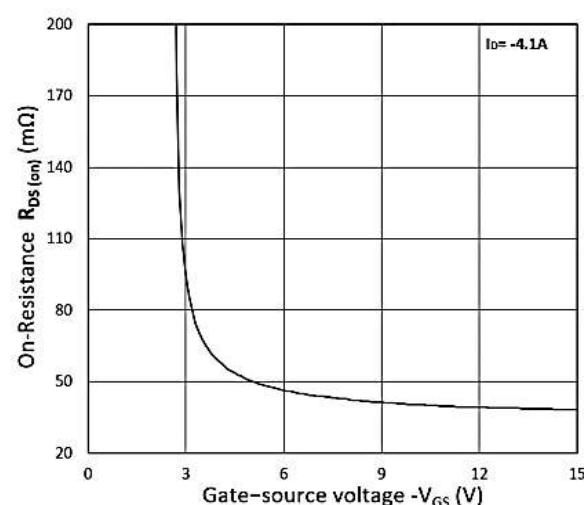
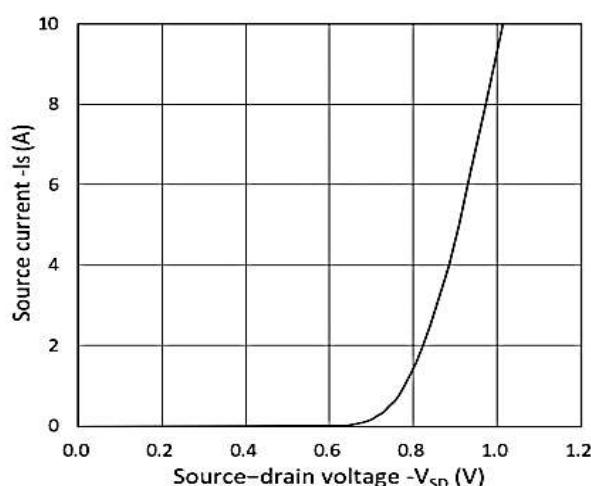
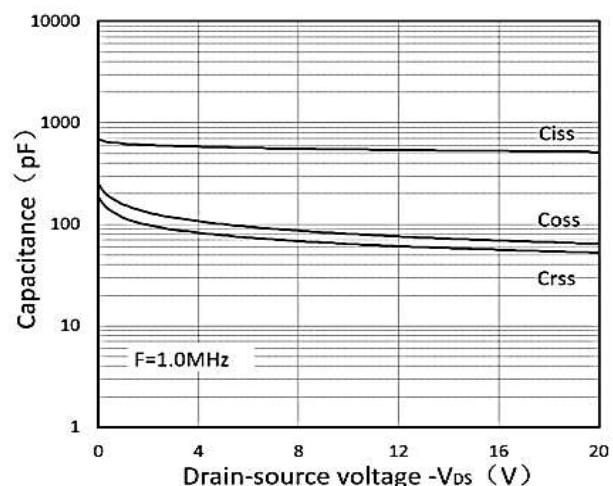
Characteristics	Symbols	Value	Units
Drain-Source Voltage	V_{DS}	-30	V
Gate - Source Voltage	V_{GS}	± 20	V
Continuous Drain Current, $-V_{GS} @ -10V^1$ @ $T_A=25^\circ\text{C}$	I_D	-7	A
Continuous Drain Current, $-V_{GS} @ -10V^1$ @ $T_A=70^\circ\text{C}$	I_D	-4.3	A
Pulsed Drain Current ²	I_{DM}	-21	A
Single Pulse Avalanche Energy ³	E_{AS}	81.2	mJ
Total Power Dissipation ⁴ @ $T_A=25^\circ\text{C}$	P_D	1.5	W
Storage Temperature Range	T_{STG}	-55 to +150	°C
Operating Junction Temperature Range	T_J	-55 to +150	°C
Thermal Resistance Junction-Ambient ¹	$R_{\theta JA}$	85	°C/W
Thermal Resistance Junction-Case ¹	$R_{\theta JC}$	25	°C/W

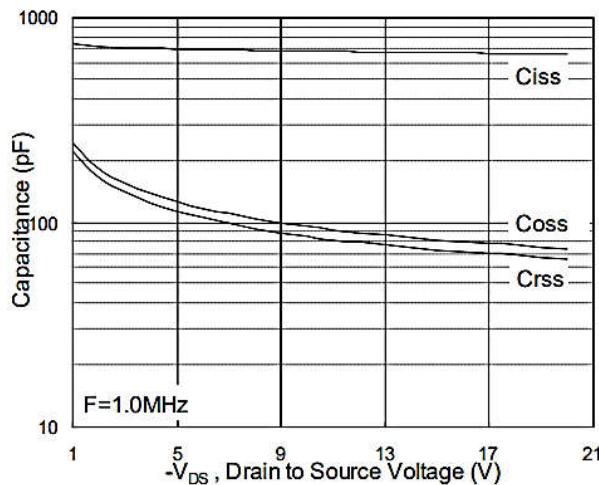
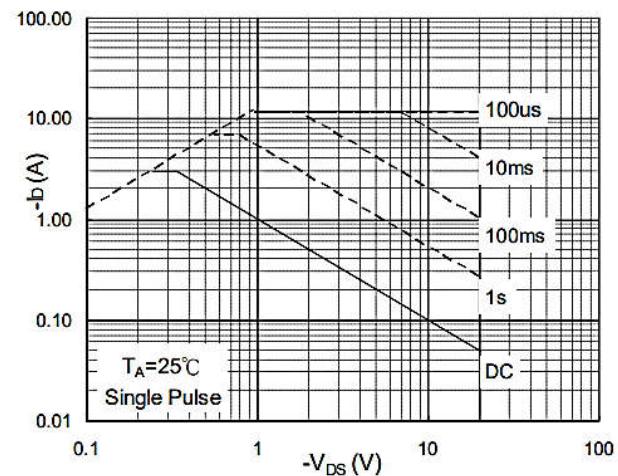
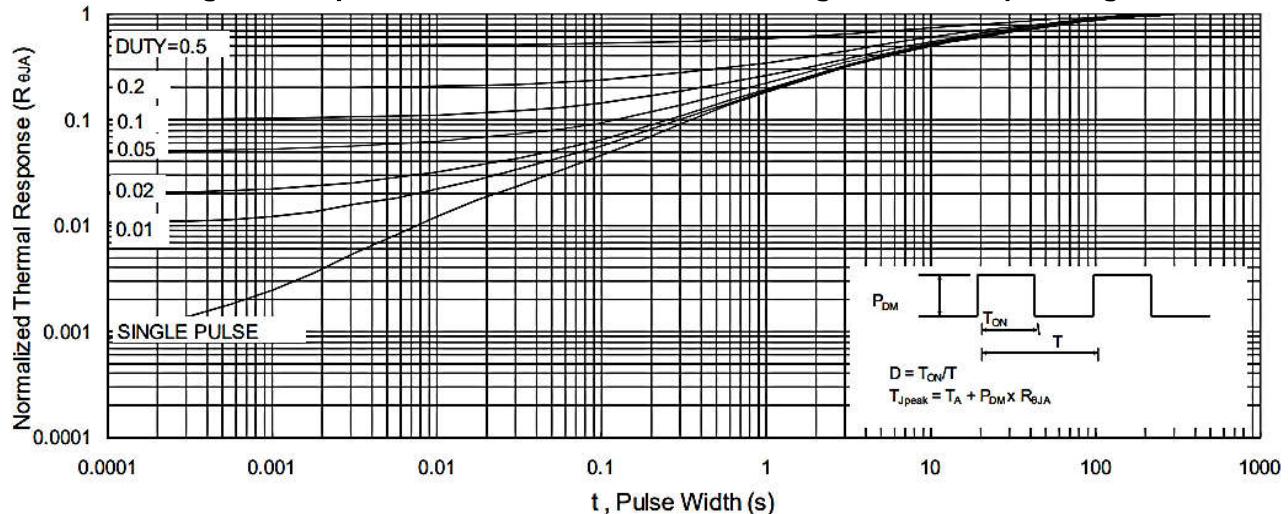
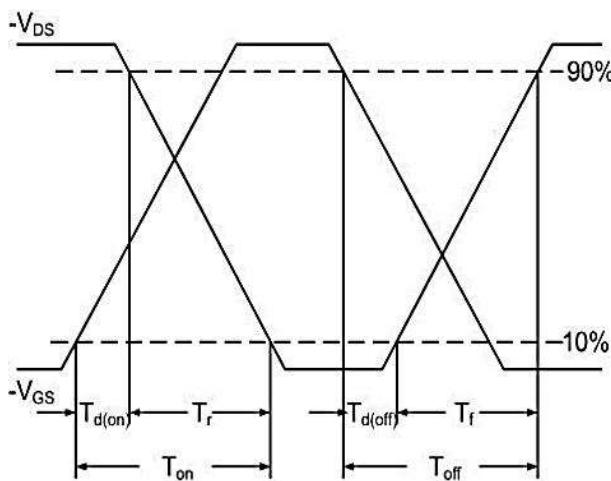
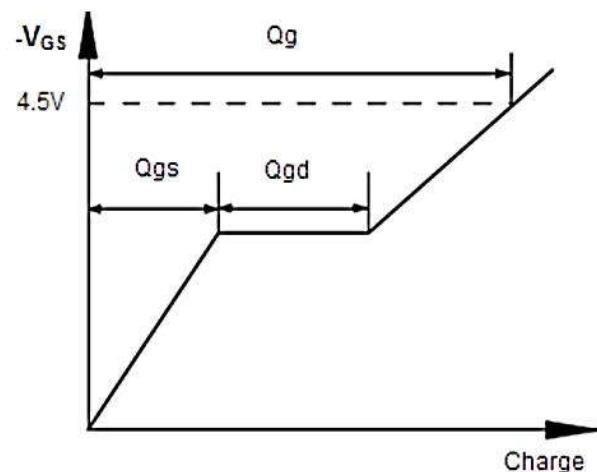
Maximum Ratings at Tc=25°C unless otherwise specified

Characteristics	Test Condition	Symbols	Min	Typ	Max	Units
Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250μA	V(BR)DSS	-30	-33	-	V
Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V	I _{DSS}	-	-	-1	μA
Gate-Source Leakage	V _{GS} =±20V, V _{DS} =0V	I _{GSS}	-	-	±100	nA
Gate-Source Threshold Voltage ³	V _{DS} =V _{GS} , I _D =-250μA	V _{GS(th)}	-1	-1.6	-2.5	V
Drain-Source on-State Resistance ³	V _{GS} =-10V, I _D =-4.1A	R _{DS(ON)}	-	37	48	mΩ
	V _{GS} =-4.5V, I _D =-3.0A		-	58	65	
Input Capacitance	V _{DS} =-15V V _{GS} =0V f=1MHz	C _{iss}	-	530	-	pF
Output Capacitance		C _{oss}	-	70	-	
Reverse Transfer Capacitance		C _{rss}	-	56	-	
Turn-on delay time ⁴	V _{GS} =-10V V _{DS} =-15V R _L = 15 Ω R _{GEN} =2.5Ω	t _{d(on)}	-	14	-	ns
Rise Time ⁴		T _r	-	61	-	
Turn-Off Delay Time ⁴		t _{d(OFF)}	-	19	-	
Fall Time ⁴		t _f	-	10	-	
Total Gate Charge ⁴	V _{GS} =-10V V _{DS} =-15V I _D =-4.1A	Q _g	-	6.8	-	nC
Gate-Source Charge ⁴		Q _{gs}	-	1.0	-	
Gate-Drain Charge ⁴		Q _{gd}	-	1.4	-	
Diode Forward Voltage	V _{GS} =0V, I _S =-4.1A	V _{SD}	-	-	-1.2	V

Note :

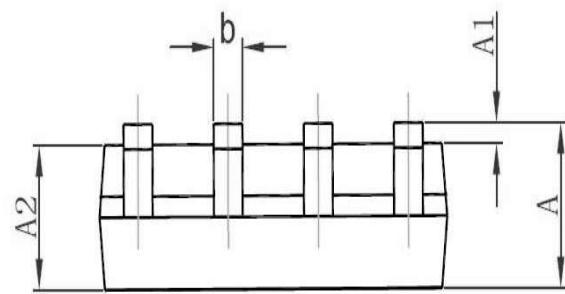
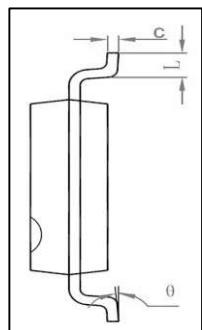
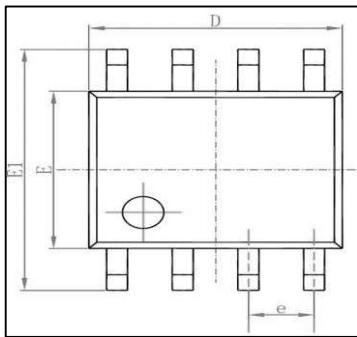
- 1、The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2、The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%
- 3、The power dissipation is limited by 150°C junction temperature
- 4、The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

Ratings and Characteristic Curves
Typical Characteristics

Figure 1. Output Characteristics

Figure 2. Transfer Characteristics

Figure 3. RDS(ON) vs. ID

Figure 4. R DS(ON) vs. V GS

Figure 5. IS vs. VSD

Figure 6. Capacitance Characteristics

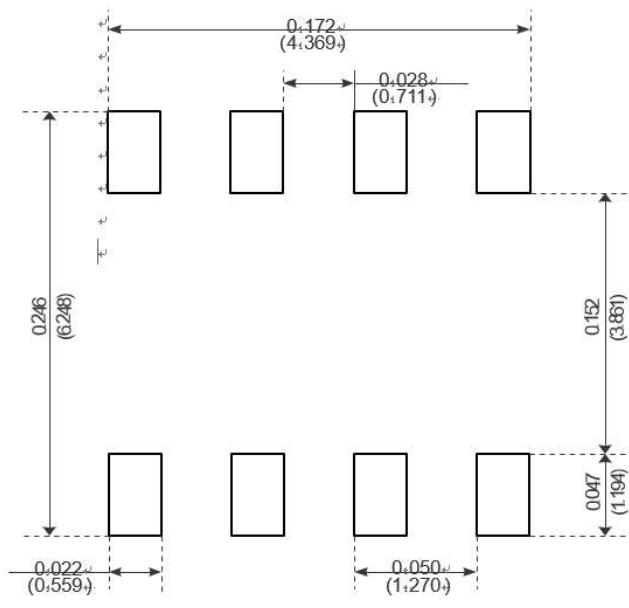
Ratings and Characteristic Curves

Figure 7 Capacitance

Figure 8 Safe Operating Area

Figure 9 Normalized Maximum Transient Thermal Impedance

Figure 10 Switching Time Waveform

Figure 11 Gate Charge Waveform

Package Outline Dimensions Millimeters

SOP-8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270 (BSC)		0.050 (BSC)	
L	0.400	1.270	0.016	0.050
θ	0°	8°	0°	8°



Recommended Minimum Pads